

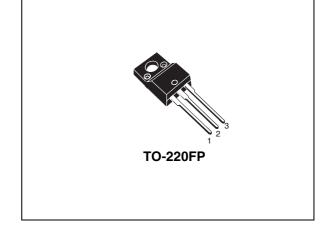
STP5NK65ZFP

N-channel 650 V, 1.5 Ω, 4.5 A TO-220FP Zener-protected SuperMESH™ Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)} max	I _D	Pw
STP5NK65ZFP	650 V	< 1.8 Ω	4.5 A	25 W

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability
- Improved ESD capability



Applications

■ Switching application

Description

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage Power MOSFETs including revolutionary MDmesh™ products

Figure 1. Internal schematic diagram

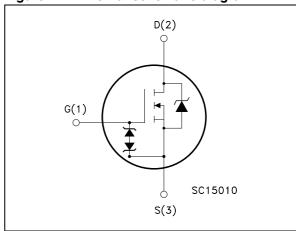


Table 1. Device summary

Order codes	Marking	Package	Packaging
STP5NK65ZFP	P5NK65ZFP	TO-220FP	Tube

April 2009 Doc ID 15565 Rev 1 1/12

Electrical ratings STP5NK65ZFP

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V _{GS} = 0)	650	V
V _{GS}	Gate- source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25 °C	4.5 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	3.1 ⁽¹⁾	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	18 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T _C = 25 °C	25	W
	Derating factor	0.6	W/°C
V _{ESD(G-S)}	Gate source ESD (HBM-C=100 pF, R=1.5 kΩ)	2000	V
dv/dt (3)	Peak diode recovery voltage slope	4.5	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T _C =25 °C)	2500	V
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	V

^{1.} Limited only by maximum temperature allowed

Table 3. Absolute maximum ratings

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case Max	5	V
R _{thj-amb}	Thermal resistance junction-ambient Max	62.5	V
T _I	Maximum lead temperature for soldering purpose	300	Α

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	4.2	Α
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	170	mJ

^{2.} Pulse width limited by safe operating area

^{3.} $I_{SD} \leq$ 5.7 A, di/dt \leq 200 A/ μ s, VDD =80% $V_{(BR)DSS}$.

2 Electrical characteristics

(Tcase =25 °C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D =1 mA, V _{GS} = 0	650	-	-	٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} =max rating V _{DS} =max rating @125 °C	-	-	1 50	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V	1	1	±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 50 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 2.1 \text{ A}$	-	1.5	1.8	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} (1)	Forward transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 2.1 \text{ A}$	-	5	-	S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{MHz,}$ $V_{GS} = 0$	-	680 80 17	-	pF pF pF
C _{oss eq.} (2)	Equivalent output capacitance	$V_{GS} = 0$, $V_{DS} = 0$ to 480 V	ı	98	ı	pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 520 V, I_{D} = 4.5 A, V_{GS} = 10 V Figure 16	1	25 4.4 13.7	35	nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%.

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$\begin{matrix} t_{\rm d(on)} \\ t_{\rm r} \\ t_{\rm d(off)} \\ t_{\rm f} \end{matrix}$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 325 \text{ V}, I_{D} = 2.1 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ Figure 15	•	20 15 140 40	1	ns ns ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time Fall time Cross-over time	$V_{DD} = 325 \text{ V}, I_{D} = 2.1 \text{ A}, \\ R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V} \\ \textit{Figure 15}$	1	12 7 15	ı	ns ns ns



^{2.} $C_{\rm oss~eq.}$ is defined as a constant equivalent capacitance giving the same charging time as $C_{\rm oss}$ when $V_{\rm DS}$ increases from 0 to 80% $V_{\rm DSS.}$

Electrical characteristics STP5NK65ZFP

Table 8. Source Drain Diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-	-	4.5 18	A A
V _{SD} ⁽²⁾	Forward On voltage	I _{SD} = 4.5 A, V _{GS} = 0	-	-	1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 4.5 A, di/dt = 100 A/µs V_{DD} = 100 V, T_j = 150 °C Figure 20	-	375 1.76 10	-	ns nC A

- 1. Pulse width limited by safe operating area.
- 2. Pulsed: Pulse duration = $300 \mu s$, duty cycle 1.5%.

Table 9. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-source breakdown voltage	lgs=± 1mA (open drain)	30	-	-	٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

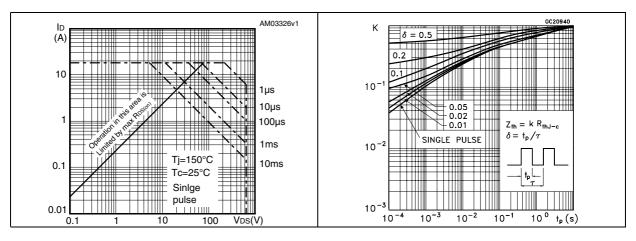


Figure 4. Output characteristics

Figure 5. Transfer characteristics

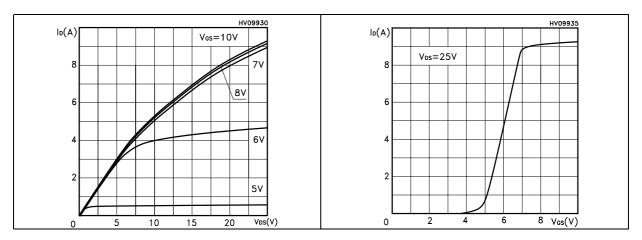
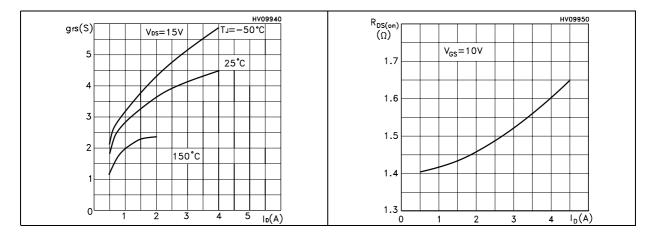


Figure 6. Transconductance

Figure 7. Static drain source on resistance



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Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

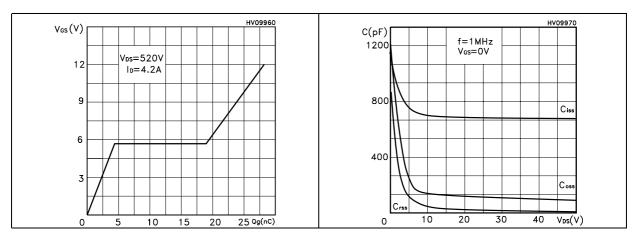


Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature temperature

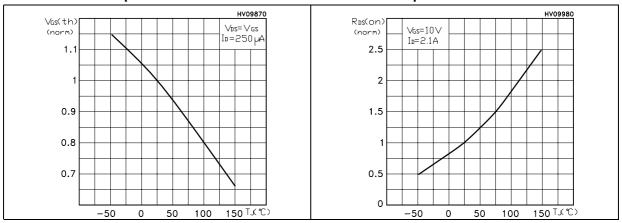


Figure 12. Source-drain diode forward characteristics

Figure 13. Avalanche energy vs starting Tj

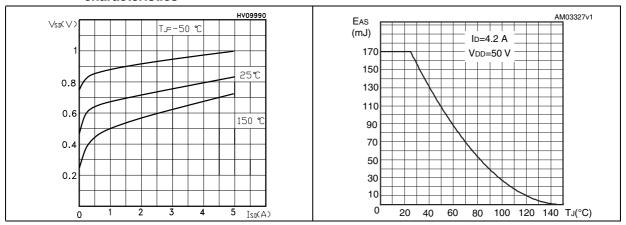
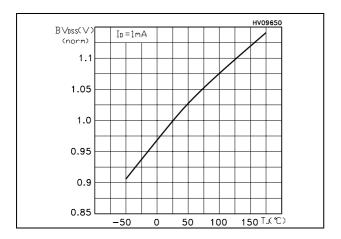


Figure 14. Normalized BV_{DSS} vs temperature





Test circuits STP5NK65ZFP

3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

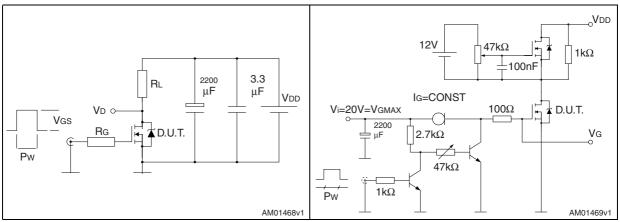


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

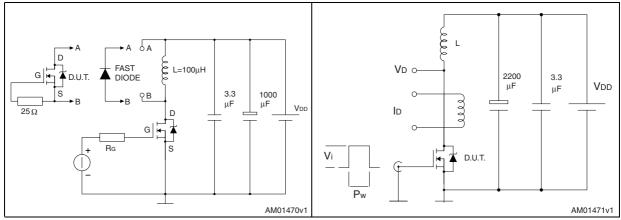
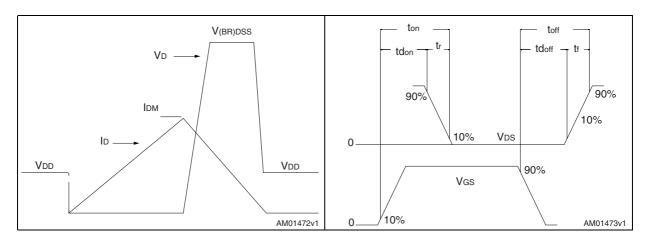


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



4 Package mechanical data

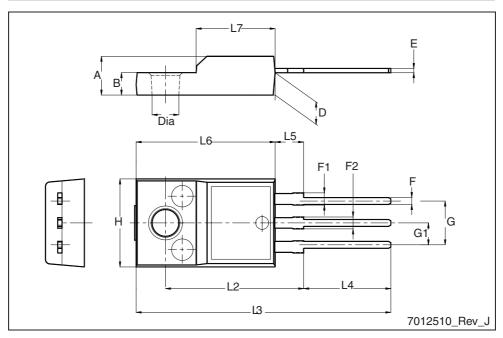
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

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TO-220FP mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.5
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2



STP5NK65ZFP Revision history

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
16-Apr-2009	1	First issue

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